COR Research Facilities Shared Laboratories & Services at UMass Lowell

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Learning with Purpose

UMass Lowell Core Research Facilities

Goals

Provide shared laboratories, facilities and services to the research community. We serve our students, faculty, industry start-ups, small and large businesses, non –profits and academic institutions.

Provide "bridge" to faculty expertise and campus resources.





Easy Access CRF

http://www.uml.edu/Research/CRF

- Apply for an account on-line
- CRF Agreement executed using e-signature
- Use on line reservation and ordering system
- Invoices emailed on a monthly basis
- Credit cards and check payment accepted
- Industry Partnership rates available. Contact CRF Business Office for more information.



Current Core Research Facilities

http://www.uml.edu/research/CRF/

Nanofabrication Laboratory, Lab Director, Thomas Ferraguto

- 22 Instruments, Class 100, 1000, 10,000 Clean Room
- Location: Saab ETIC

Materials Characterization Lab, Lab Manager: Earl Ada

- 29 Instruments
- Locations: Olney Science Center and Saab ETIC

NERVE Center, Lab Manager: Adam Norton

(New England Robotic Validation and Experimentation)

- 29 robotic test courses (NIST replicated)
- Location: 1001 Pawtucket Avenue
- Thermal & Mechanical Properties
 - 4 Instruments with plans for expansion
 - Location: Saab ETIC



Saab Emerging Technologies & Innovation Center (ETIC)

84,000 square foot facility Location of NFL,TMP, MCL Core Research Facility and CRF Business Office



NanoFabrication Laboratory (NFL)

Class 100, 1000, 10,000 with Bio-Bay













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CRISP TM searchable database http://www.uml.edu/Research/CRF

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https://crf.uml.edu/index.php?g=SEM&sr=Search ☆ 〓 **UMASS** LOWELL earning with Purpo Search for Resources or Facilities CRF Umass @ UMass Lowell Industry Demo Browse by Research Laboratory Browse by Resource Type SEM Search Reservations Cart 7 Resources found searching for SEM: Atomic Force \$245.00 Microscope (Veeco Dimension 3100) Cryo-Ultramicrotome Leica EM UC6 Assisted @ Reserve \$245/labhour Materials Characterization Lab 03/14/14 Core Research Facility Rates Sample prep instrument for SEM, TEM and AFM imaging Self No Charge Training: No Charge Atomic Layer \$278.00 Deposition (FIJI) Training @ \$278/labhour 03/29/14 Field-emission Scanning Electron Microscope JEOL JSM 7401F Unit 1 Reserve . Materials Characterization Lab Robotic Validation \$1,983.00 Core Research Facility and Testing Rates Facility (Courses Note: Our shared laboratory is used by a variety of researchers. We ask that you make reasonable time estimates when scheduling. Billing is completed according to the reservation which is to reflect actual use (in Self: \$64/hr replicated from Assisted: \$245/lhr NIST, designed in collaboration with Training: \$245/lhr fifteen minute increments). Please notify the Lab Director if use time is reduced due to equipment or facility malfunction. 24 hours cancellation is the U.S. Army, and others) required by e-mail to the Lab Director. Self @ \$1,983/each Sample Characterization Equipment 03/30/14 1 each Training Estimates and Prerequisite 6 Hours and must have demonstrated proficiency in using JEOL 6390 SEM Total: \$2,506.00 Features: Electron optical column: Cold-cathode tip field emission gun; 1.0 nm resolution at 15 kV accelerating voltage; 0.1 – 30 kV accelerating voltage **Check Out**

range; 25x - 1,000,000x magnification range 2. Detectors: one chamber-mounted Everhart-Thornley type secondary electron detector, one semi-in-lens secondary electron detector with r-filter and secondary electron signal enhancer, one pneumatically retractable solid state back-scattered electron detector for topographical and compositional image contrast 3. Specimen chamber and stage: large specimen exchange port accommodating 4 inch diameter and 40 mm height samples, eucentric goniometer stage with PC-automated X-, Y- and R- axes and manual Z- and Tilt- axes X-ray Micro-analysis using Energy Dispersive Spectroscopy: EDAX Genesis XM2 Imaging System composed of a 10 mm2 Si(Li) detector with

SUTW window for detection of all elements down to Be, and the digital electronics and software for image acquisition and x-ray signal mapping and qualitative and quantitative analysis canabilities Nanometer Patterning Generation System for e-beam lithography

includes NPGS PCI 516A high speed lithography board, Deben PCD beam blanking system, NPGS v9.0 control software and DesignCAD LT2000



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CRF FYI

See website for more details: http://www.uml.edu/Research/CRF/

- ✤ Of 138 accounts, 65 are industry
- Of 375 "users" , 110 external "users"
- More that 75 instruments available within CRF program.
- More than 450 resources available through research services
- Additional CRF's to be added in the near future
- Call for a tour-978.934.6421



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